Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/663,683	NISHIYAMA ET AL.
Examiner	Art Unit
Yevgeny Valenrod	1621

SEARCHED					
Class	Subclass	Date	Examiner		
_			•		
١					
		·			
		-			
			·		
	-		<u> </u>		
	*				

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
EAST	·				
	•				
	Subclass	Subclass Date			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
STIC STN structure/inventor search see transcript	11/1/2006	YV		
Inventor search, eDAN, EAST, PALM	10/31/2006	YV.		
EAST class/subclass + text search, Classes searched: 548/400; 546/305, 315, 322, 326. US-PGPUB; USPAT; USOCR; EPO; JPO; DERW	11/1/2006	YV		
Patentability conference with Tom McKenzie	11/1/2006	w		
STN structure search	9/6/2006	YV		
	·			